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Fairchild Semiconductor FDC638P

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September 2001

FDC638P

P-Channel 2.5V PowerTrench Specified MOSFET

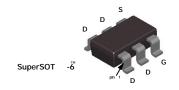
General Description

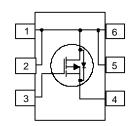
This PChannel 2.5V specified MOSFET is produced Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance

These devices are well suited for battery power applications: load switching and power management, battery charging circuits, and DC/DC conversion.

Features

- $-4.5 \text{ A}, -20 \text{ V}. R_{DS(ON)} = 48 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 65 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$
- Low gate charge (10 nC typical)
- High performance trench technology for extremely low R_{DS(ON)}
- SuperSOT [™] –6 package: small footprint (72% smaller than standard SO-8; low profile (1mm thick)





Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|--|-----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | -20 | V |
| V _{GSS} | Gate-Source Voltage | | ±8 | V |
| l _D | Drain Current - Continuous | (Note 1a) | -4.5 | Α |
| | - Pulsed | | -20 | |
| P _D | Power Dissipation for Single Operation | (Note 1a) | 1.6 | W |
| | | (Note 1b) | 0.8 | vv |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 78 | °C/W |
|-------------------|---|-----------|----|------|
| R ₀ JC | Thermal Resistance, Junction-to-Case | (Note 1) | 30 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|---------|-----------|------------|------------|
| .638 | FDC638P | 7" | 8mm | 3000 units |



| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---|---|--|------|----------------|----------------|-------|
| Off Char | acteristics | | | I | I | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$ | -20 | | | V |
| <u>ΔBV_{DSS}</u> ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = -250 \mu A$, Referenced to 25°C | | -14 | | mV/°C |
| l _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ | | | -1 | μΑ |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = -250 \mu A$ | -0.4 | -0.8 | -1.5 | V |
| ΔV _{GS(th)} ΔT _J | Gate Threshold Voltage Temperature Coefficient | $I_D = -250 \mu\text{A}$, Referenced to 25°C | | 3 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -3.8 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{ T}_J = 125^{\circ}\text{C}$ | | 39 52 54 | 48 65 72 | mΩ |
| I _{D(on)} | On-State Drain Current | $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$ | -20 | | | Α |
| g FS | Forward Transconductance | $V_{DS} = -10 \text{ V}, \qquad I_{D} = -4.5 \text{ A}$ | | 15 | | S |
| Dynamic | : Characteristics | | | • | • | • |
| Ciss | Input Capacitance | $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ | | 1160 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 195 | | pF |
| C _{rss} | Reverse Transfer Capacitance | 7 | | 105 | | pF |
| Switchin | g Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = -5 \text{ V}, \qquad I_D = -1 \text{ A},$ | | 12 | 22 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$ | | 9 | 18 | ns |
| t _{d(off)} | Turn-Off Delay Time | 1 | | 33 | 53 | ns |
| t _f | Turn-Off Fall Time | 1 | | 12 | 22 | ns |
| Q _g | Total Gate Charge | $V_{DS} = -10 \text{ V}, I_{D} = -4.5 \text{ A},$ | | 10 | 14 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = -4.5 V | | 2.2 | | nC |
| Q_{gd} | Gate-Drain Charge |] | | 1.5 | | nC |
| Drain-S | ource Diode Characteristics a | and Maximum Ratings | | | | |
| l _s | Maximum Continuous Drain-Source I | | | | -1.3 | Α |
| V _{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = -1.3 \text{ A} \text{(Note 2)}$ | | -0.73 | -1.2 | V |

Notes

 R_{BUA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BUC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) 78°C/W when mounted on a 1in² pad of 2 oz copper



b) 156°C/W when mounted on a minimum pad of 2 oz copper

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%



Typical Characteristics

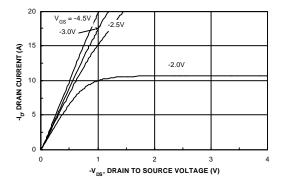


Figure 1. On-Region Characteristics.

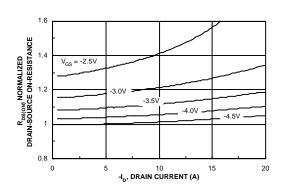


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

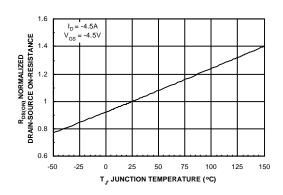


Figure 3. On-Resistance Variation with Temperature.

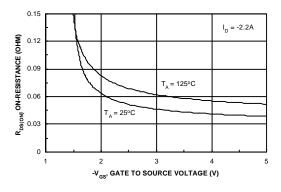


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

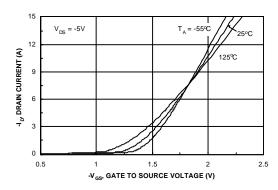


Figure 5. Transfer Characteristics.

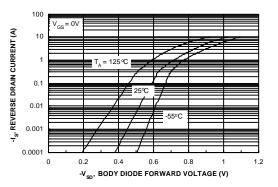
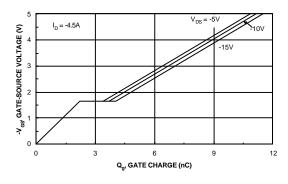


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.



Typical Characteristics



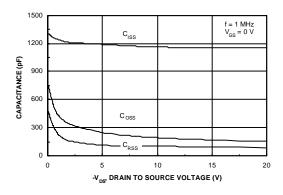
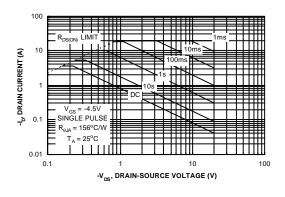


Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



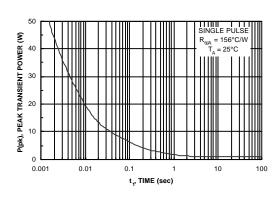


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

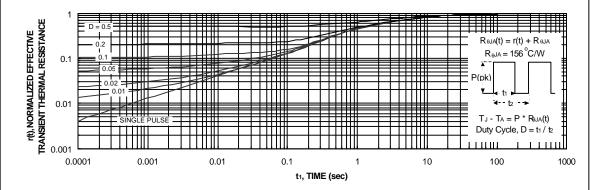


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b Transient thermal response will change depending on the circuit board design.



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